

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/786,072 ISHII ET AL.	
		Examiner	Art Unit	Page 1 of 1 Patrick A. Darno 2163

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0091658 A1	04-2005	Kavalam et al.	718/104
*	C	US-5,260,551	11-1993	Wiik et al.	340/5.28
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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